## Notice of References Cited Application/Control No. 10/511,266 Examiner Leonard R. Leo Applicant(s)/Patent Under Reexamination REIER ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-1,735,807 A	11-1929	Swank	165/149
*	В	US-4,763,723 A	08-1988	Granetzke	165/67
*	С	US-5,257,662 A	11-1993	Osborn	165/173
*	D	US-5,323,848 A	06-1994	Naty et al.	165/145
*	E	US-5,429,182 A	07-1995	Hanafusa	165/67
*	F	US-5,456,089 A	10-1995	O'Brien	62/298
*	G	US-6,000,460 A	12-1999	Yamanaka et al.	165/67
*	н	US-6,269,868 B1	08-2001	Welding et al.	165/149
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-		-	·

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	,				
	0					
	Р					
	Q					
	R					
	s					,
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	J	
	٧	
	W	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.